

Institute of Electronic System WUT

involvement in studies of plasma physics and fusion research programme

➤ ELHEP laboratory activities:

- ❑ EFDA, JET Tokamak, Culham - plasma impurity measurement system – X-ray spectrometer at KX1 for W(Tungsten) and Ni (Nickel) based on GEM detectors
- ❑ CCFE, MAST tokamak, Culham – control and monitoring upgrade for superconductor magnets
- ❑ CEA, WEST tokamak, Cadarache - Development of soft X-ray GEM based detecting system for tomographic tungsten focused transport monitoring

ELHEP staff & area of interest

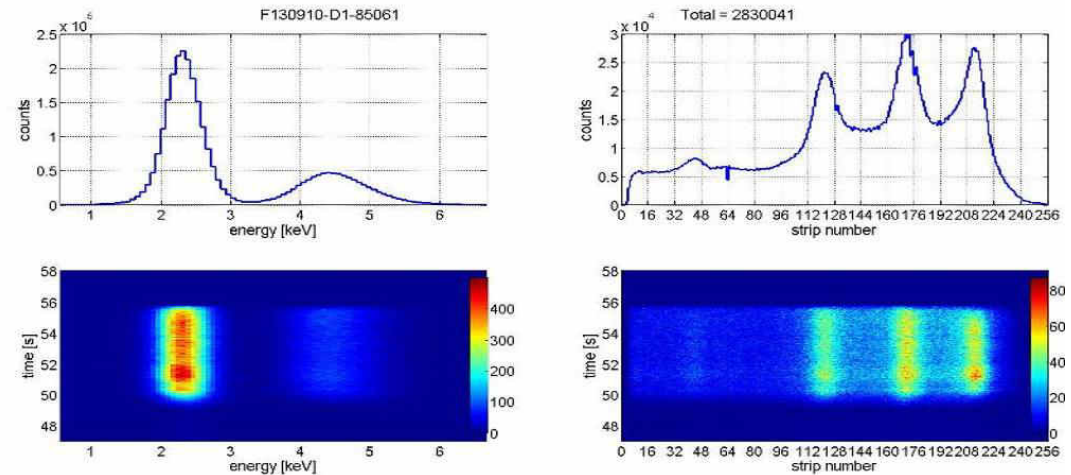
- Krzysztof Poźniak, DsC, PhD, Head – FPGA firmware, HEP metrology
- Wojciech Zabołotny, PhD – FPGA & DSP implementation
- Grzegorz Kasprowicz, PhD – fast & multichannel hardware designer
- Andrzej Wojeński, PhD – FPGA & embedded systems specialist
- Rafał Krawczyk, PhD – uP & DSP high performance computing
- Maciej Linczuk, PhD – DSP algorithms
- Paweł Linczuk, PhD stud. – uP high performance systems & interfaces
- Michał Gaska, PhD stud. – control & monitoring system
- Piotr Kolasiński, PhD stud. – FPGA firmware
- Radosław Cieszewski, PhD stud. – HLS for FPGA, C/C++ specialist
- >10 BSc and MSc students

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- *FPGA technologies* – hardware & firmware design, multi-FPGA systems
 - *DSP technologies* – uP-DSP & FPGA-DSP designs, real-time algorithms
 - *Optoelectronic* – multi Tbps synchronous data transmission
 - *PCB design* (multi GHz) – multilayer EMC/SI verified and tested
 - *Hardware testing* – EMC/SI simulation and measurements

T-GEM system on KX1 at JET tokamak



2 GEM system installation

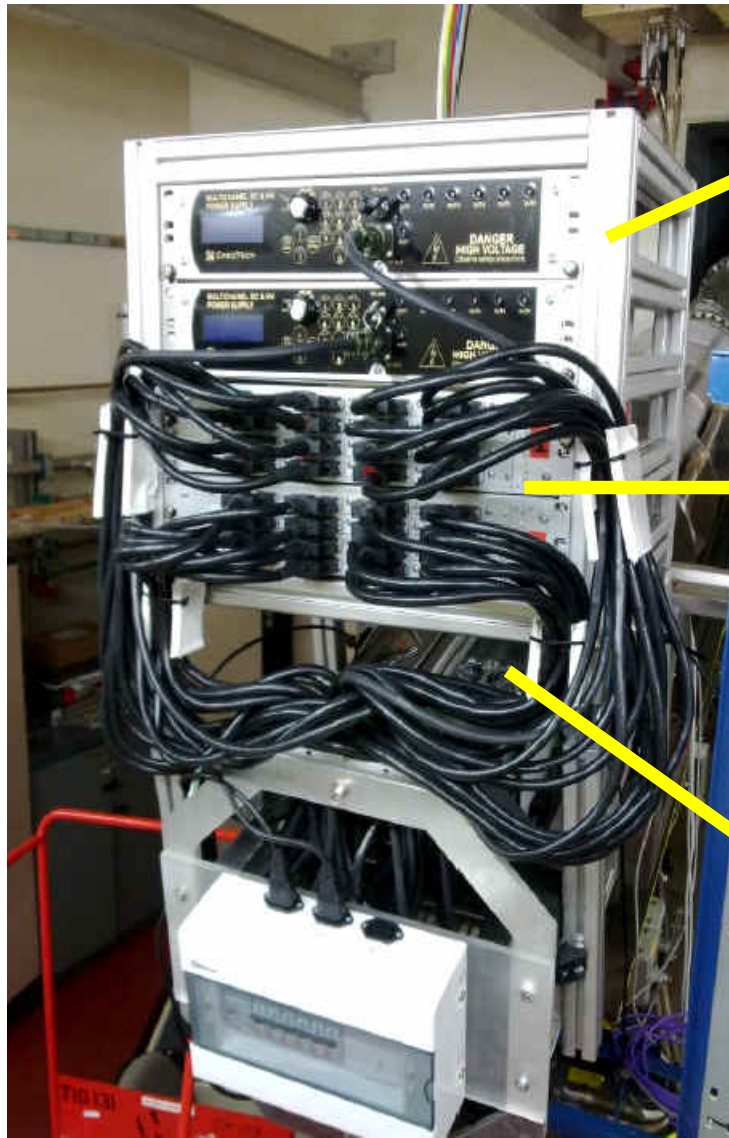


Exemple of result -Tungsten spectrum evolution in time (resolution 10 ms)

Parameter name	Unit	Count
Channel number	#	256
Analog signal probe frequency	MHz	77.78
Digital signal size	bits	10
Minimum histogramming time	s	0.01
Maximum histogram measures (for 512 charge levels)	#	2000
Maximum histogram measures (for 256 charge levels)	#	4000
Maximum histogram measures (for 128 charge levels)	#	8000

System basic specification

T-GEM system on KX1 at JET tokamak



2 GEM system installation



7-ch. programmable HV
& $\pm 5V$ power supply

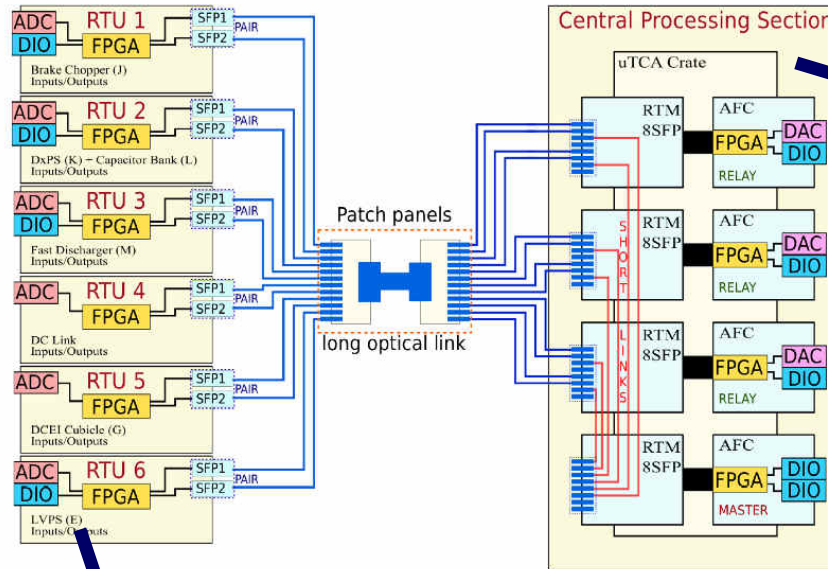


FPGA based modular
digital system

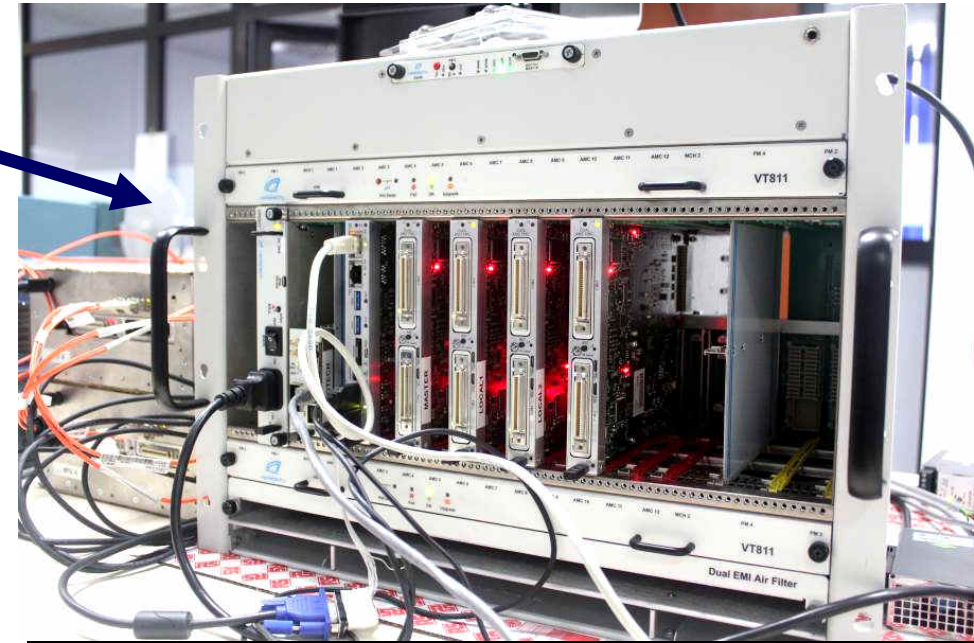


T-GEM & analog FEBs

Diagnostic system for MAST tokamak



Complete system overview

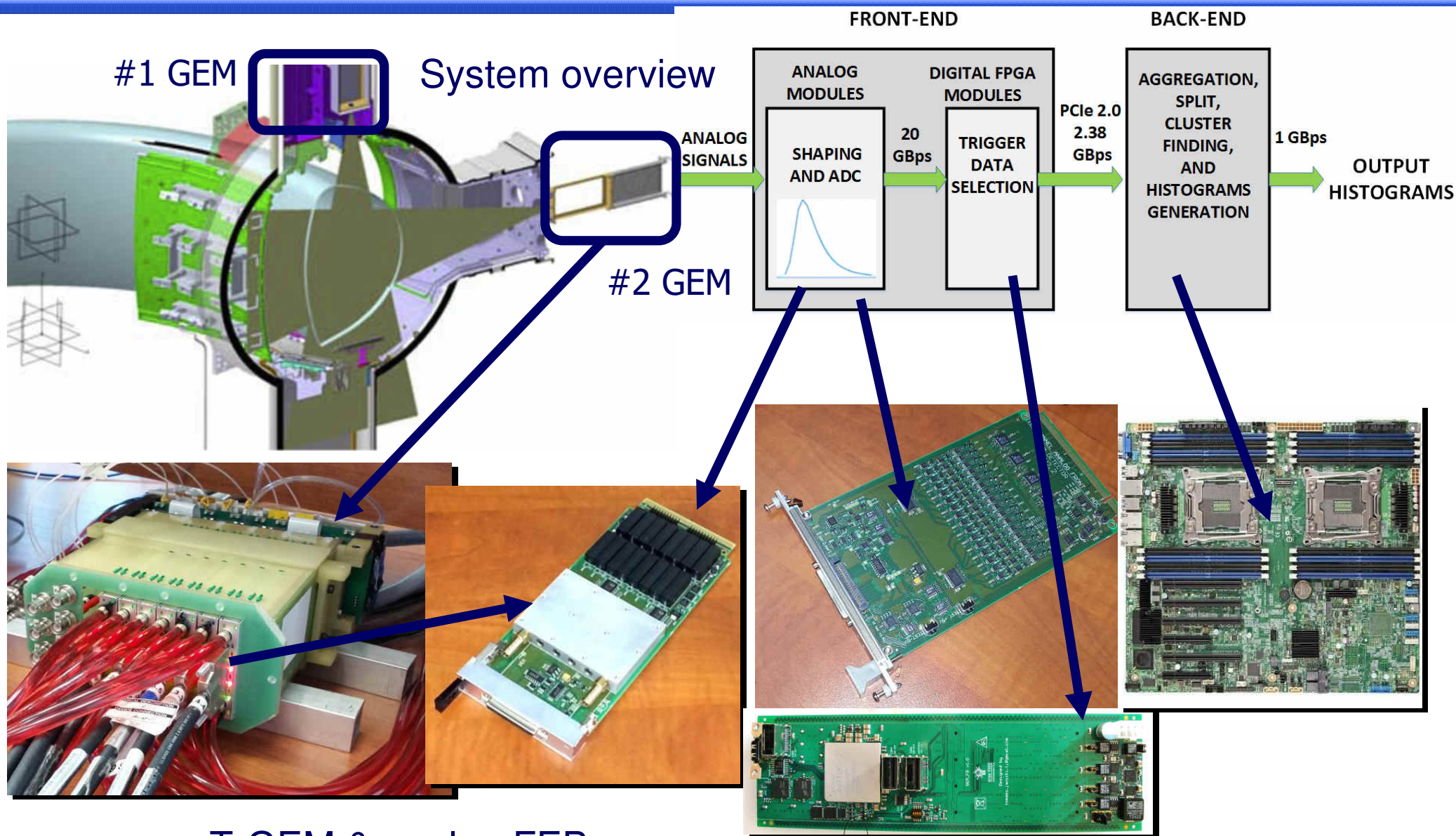


uTCA based diagnostics system



High voltage diagnostic system

Tungsten topographic for WEST tokamak



T-GEM & analog FEBs

FPGA & PC based digital system

Tungsten topographic for WEST tokamak

Parameter	Hardware histogramming system	Serial acquisition system (new system, under design)
# channels	256	Up to 2048 (512 per one PCI-E switch per one PCIe slot)
Sampling freq.	77.78 MHz	50.0 - 125.0 MHz
Samples resolution	10 bits	14 bits
Min. time of histogramming	10 ms	1 ms or continuous-time acquisition mode
Strip charge rate	About 2 MHz	About 5 MHz
Used FPGA	21 Xilinx Spartan6	4 newest Xilinx Artix7 (256 ch)
Type of GEM detector	1 dimensional, based on stripes	1D, 2D, different readout structures (XY, YUV)
Measurement mode	Analog current-to-voltage mode	Fast hybrid integrator, direct sampling or fast discriminator
System control	Software based on C/Python	FCS + C++ readout software
Data channels	PCI-Express, fast serial links	PCI-Express, Gigabit transceivers
Other features	Modular, flexible construction	Synchronization interface
	FMC standard	Tree structure, easy to extend